INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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First Named Inventor Corl, et al.

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Examiner Karen E. Toth

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(Multiple sheets used when necessary)
SHEET 1 OF 1

U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	
	1	3865897	2/11/1975	Falender et al.		
	2	2003105453 A1	6/5/2003	Stewart, Mark T.		

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Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T ¹
	3	EP 0083969 A	7/20/1983	Critikon Inc.		
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	5	WO 9510975 A	4/27/1995	Washington Res Found		

	NON PATENT LITERATURE DOCUMENTS				
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	6	Written Opinion of the International Searching Authority, Application No. PCTUS0429558, April 10, 2007.			
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	8	Patent Office of the People's Republic of China, First Office Action, Application No. 200480030397.3, May 9, 2008.			

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /K.T./

Examiner Signature	/Karen Toth/ (01/29/2009)	Date Considered	

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.